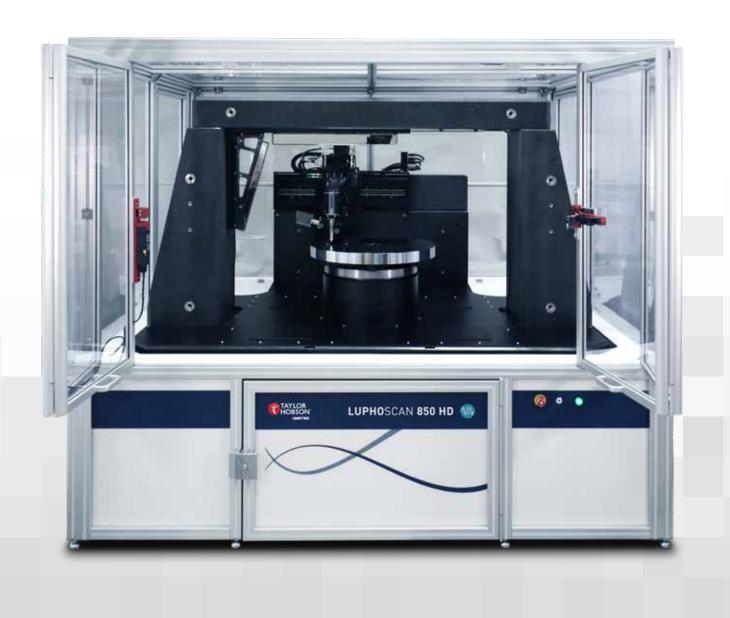


LUPHOSCAN 850 HD

The world's most versatile, non-contact 3D form measurement platform for advanced large diameter optical surfaces



LUPHOSCAN 850 HD

Advanced 3D Optics Metrology

Accurate measurement of aspheres, diffractives and freeforms up to $\emptyset 850 \text{ mm}$

LUPHOScan: A truly diverse range of non-contact metrology solutions

Taylor Hobson are pushing the boundaries of large optics metrology. Our expert metrologists are delighted to announce the launch of the LUPHOScan 850 HD.

Built on the foundations of the world renowned LUPHOScan HD platform, the LUPHOScan 850 HD delivers stable noncontact metrology for large complex optics applications.

The instrument has been developed working and listening closely to our many partners in optics manufacturing. Our metrologists understand the importance designing a system that delivers highly accurate, repeatable and reliable measurement data.

Results you can trust

The LUPHOScan with our forward-thinking innovation delivers true measurement accuracy

Revolutionary measurement capability

Highly accurate

• Capable of accurate and repeatable form error measurements to $< \lambda/20$ (PV99i) and RMS from 5 nm^{*}

Class-leading measurement flexibility

• From 5 mm up to 850 mm (dia.) x 210 mm (height)

High data density

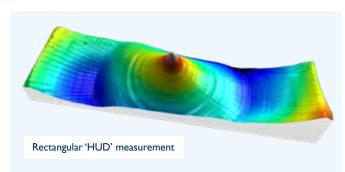
 Data density up to 6 million data points for accurate analysis of mid-spatials at large diameters

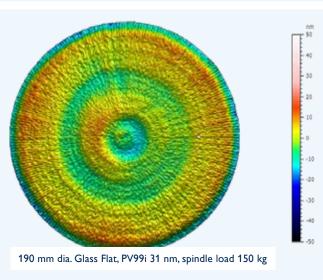
Freeform measurement

• Up to ±8 degs for tangential slopes (radial slopes 90 degs)

Almost every material

• Transparent, specular, opaque, polished or ground





Optimised technology for measurement accuracy and reproducibility

Granite metrology frame

 Homogeneous metrology frame ensures accurate compensation for thermal expansion with optimised design to minimise vibration.

Real time compensation of ambient conditions

• 4 Temperature and 1 air pressure sensors

Advanced material design for best stability

• Bespoke carbon fibre arms designed and optimised to reduce system noise

Automatic centre and level

Consistently accurate results through complete measurement automation

Ultra high repeatability

10 nm at 600 mm with 150 kg load (PV99i)

Large work load

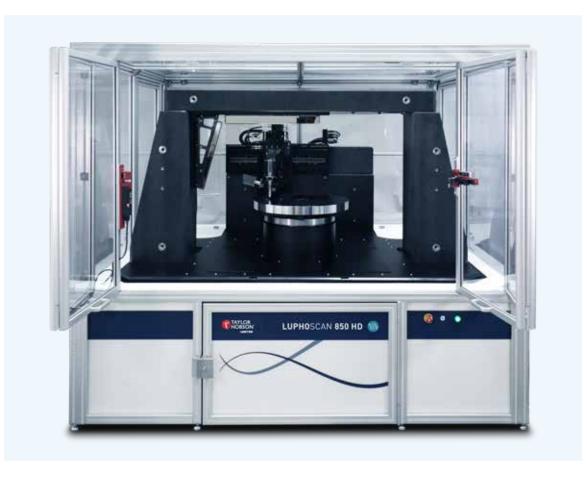
Up to 300 kg

Measurement capability

RMS from 5 nm

Freeform measurement

OAP, Toric, True freeforms









Measurement principle

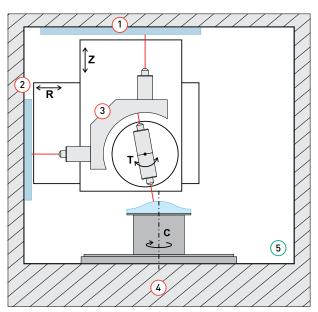
The probe tracks the form of the surface as the optic rotates, describing a spiral. This technique allows virtually any optical surface form to be measured.

Advanced probe technology

- Allows interruption of the probe during measurements without impacting measurement accuracy
- Critical for measurements on interrupted surface such as segmented or rectangular parts

Reference frame

- Probe stages (R, Z, T)
- Temperature sensors (1-4)
- Object stage (C)
- Air pressure sensor (5)



LUPHOScan 850 HD reference frame

LUPHOSCAN 850 HD

Typical results

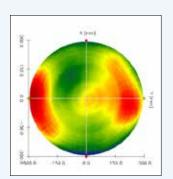
Study: repeatability and reproducibility

Repeatability study

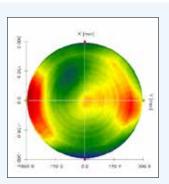
3 repeat measurements at 600 mm diameter on a precision glass flat with 150 kg additional spindle load.

Repeatability (30)

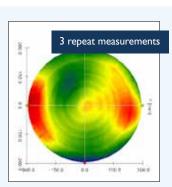
- PV99i 8 nm
- RMSi 1 nm
- PWR 0.033 µm



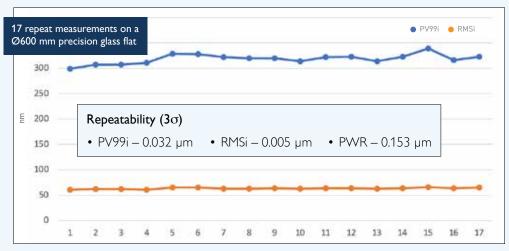
Measurement No. 1



Measurement No. 2



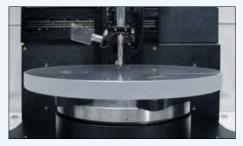
Measurement No. 3



Graph - 17 measurements taken over a 12 hour period without re-calibration (Inc. 150 kg spindle load)

Long-term repeatability

17 repeat measurements at 600 mm diameter on a precision glass flat with 150 kg additional spindle load.



Measurement of 600 mm precision glass flat

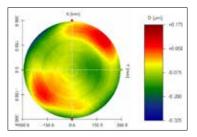
Reproducibility study

To demonstrate the accuracy and reproducibility, a Ø600 mm reference flat is measured in two different orientations with and without a 150 kg work load.

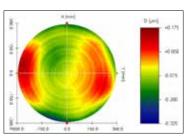
Clearly the form rotates with the system and PV99i remains stable for all orientations.

Ø600 mm reference flat

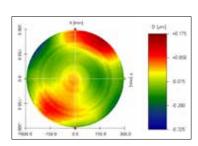
- 0° 303 nm, 57 nm RMS
- 120° 335 nm, 58 nm RMS
- 0° with 150 kg 294 nm, 60 nm RMS
- 120° with 150 kg 350 nm, 69 nm RMS



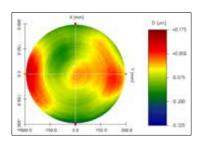
0° Orientation with no load



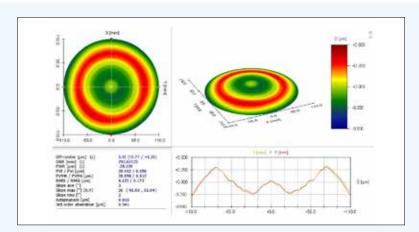
120° Orientation with no load



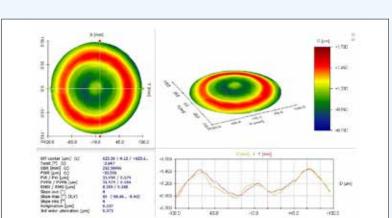
0° Orientation with 150 kg load



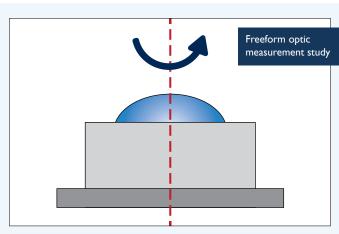
120° Orientation with 150 kg load



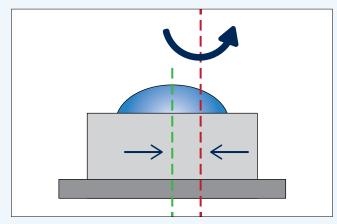
On-axis form error



10 mm off-axis form error



Test sphere measured conventionally, on axis with spindle



Test sphere offset 10 mm to spindle axis to simulate a freeform

Freeform measurement study

A large (220 mm) diameter, spherical component is measured on axis, then moved off axis.

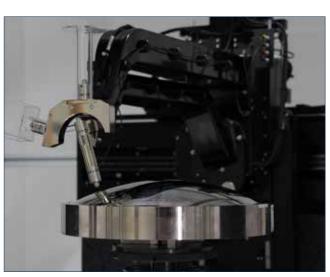
The 10 mm off-axis sphere is representative of a freeform component and allows direct comparison to the known, accurate, conventional spherical measurement.

On-axis measurement

- PV99i 0.612 μm
- RMSi 0.172 μm

Off-axis measurement

- PV99i 0.623 μm
- RMSi 0.167 μm



Measurement of 220 mm diameter simulated freeform



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- Precision Manufacturing Contract machining services for high precision applications and industries.

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Metrology Support

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Measurement of your parts is carried out by skilled technicians using industry leading instruments in accord with ISO standards.

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- Operator Training On-site instruction will lead to greater proficiency and higher productivity.
- UKAS Calibration & Testing Certification for artifacts or instruments in our laboratory or at customer's site.





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